December 1994

LM113/LM313 Reference Diode

General Description

The LM113/LM313 are temperature compensated, low voltage reference diodes. They feature extremely-tight regulation over a wide range of operating currents in addition to an unusually-low breakdown voltage and good temperature stability.

The diodes are synthesized using transistors and resistors in a monolithic integrated circuit. As such, they have the same low noise and long term stability as modern IC op amps. Further, output voltage of the reference depends only on highly-predictable properties of components in the IC; so they can be manufactured and supplied to tight tolerances.

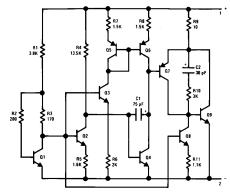
- \blacksquare Dynamic impedance of 0.3 $\!\Omega$ from 500 μA to 20 mA
- Temperature stability typically 1% over 55°C to 125°C range (LM113), 0°C to 70°C (LM313)
- Tight tolerance: $\pm 5\%$, $\pm 2\%$ or $\pm 1\%$

The characteristics of this reference recommend it for use in bias-regulation circuitry, in low-voltage power supplies or in battery powered equipment. The fact that the breakdown voltage is equal to a physical property of silicon—the energy-band gap voltage—makes it useful for many temperature-compensation and temperature-measurement functions

Features

■ Low breakdown voltage: 1.220V

Schematic and Connection Diagrams



Metal Can Package

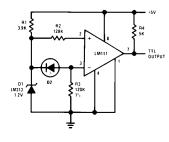


Order Number LM113H, LM113H/883, LM113-1H, LM113-1H/883, LM113-2H, LM113-2H/883, or LM313H

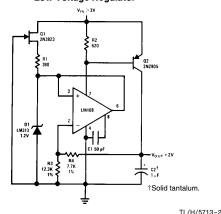
See NS Package Number H02A
TL/H/5713-1

Typical Applications

Level Detector for Photodiode



Low Voltage Regulator



IL/H/5/13

Absolute Maximum Ratings

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications. (Note 3)

 Power Dissipation (Note 1)
 100 mW

 Reverse Current
 50 mA

 Forward Current
 50 mA

 $\begin{array}{lll} \mbox{Storage Temperature Range} & -65\mbox{°C to} + 150\mbox{°C} \\ \mbox{Lead Temperature} & & & & & \\ \mbox{(Soldering, 10 seconds)} & & & & & \\ \mbox{Operating Temperature Range} & & & & \\ \end{array}$

Electrical Characteristics (Note 2)

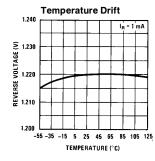
Parameter	Conditions	Min	Тур	Max	Units
Reverse Breakdown Voltage LM113/LM313 LM113-1 LM113-2	I _R = 1 mA	1.160 1.210 1.195	1.220 1.22 1.22	1.280 1.232 1.245	V V V
Reverse Breakdown Voltage Change	$0.5~\text{mA} \leq I_{ ext{R}} \leq 20~\text{mA}$		6.0	15	mV
Reverse Dynamic Impedance	$I_R = 1 \text{ mA}$ $I_R = 10 \text{ mA}$		0.2 0.25	1.0 0.8	Ω
Forward Voltage Drop	I _F = 1.0 mA		0.67	1.0	V
RMS Noise Voltage	$10 \text{ Hz} \le f \le 10 \text{ kHz}$ $I_{\text{R}} = 1 \text{ mA}$		5		μV
Reverse Breakdown Voltage Change with Current	$0.5 \text{ mA} \leq I_{\hbox{\scriptsize R}} \leq 10 \text{ mA}$ $T_{\hbox{\scriptsize MIN}} \leq T_{\hbox{\scriptsize A}} \leq T_{\hbox{\scriptsize MAX}}$			15	mV
Breakdown Voltage Temperature Coefficient	$1.0 \text{ mA} \leq I_{R} \leq 10 \text{ mA}$ $T_{MIN} \leq T_{A} \leq T_{MAX}$		0.01		%/°C

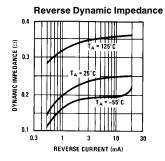
Note 1: For operating at elevated temperatures, the device must be derated based on a 150°C maximum junction and a thermal resistance of 80°C/W junction to case or 440°C/W junction to ambient.

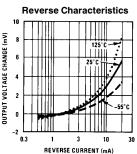
Note 2: These specifications apply for $T_A = 25^{\circ}$ C, unless stated otherwise. At high currents, breakdown voltage should be measured with lead lengths less than $\frac{1}{4}$ inch. Kelvin contact sockets are also recommended. The diode should not be operated with shunt capacitances between 200 pF and 0.1 μ F, unless isolated by at least a 100 Ω resistor, as it may oscillate at some currents.

Note 3: Refer to the following RETS drawings for military specifications: RETS113-1X for LM113-1, RETS113-2X for LM113-2 or RETS113X for LM113.

Typical Performance Characteristics







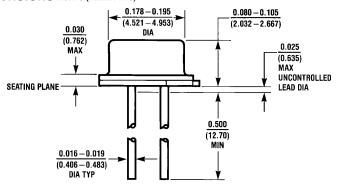
TL/H/5713-3

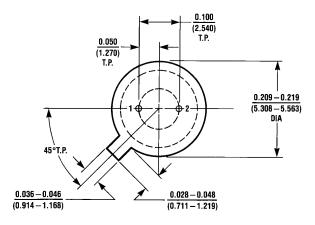
Typical Performance Characteristics (Continued) Reverse Characteristics Reverse Dynamic Impedance Noise Voltage REVERSE CURRENT (A) DYNAMIC IMPEDANCE (12) 0.1 10⁻⁵ 30 100 0.2 0.4 0.6 0.8 1.0 1.2 1k 10k 100k 100 1k REVERSE VOLTAGE (V) FREQUENCY (Hz) FREQUENCY (Hz) Response Time **Maximum Shunt Capacitance Forward Characteristics** FORWARD VOLTAGE (V) VOLTAGE SWING (V) 0.5 0 10 FORWARD CURRENT (mA) TIME (µs) CAPACITANCE (pF) TL/H/5713-4 **Typical Applications** (Continued) **Amplifier Biasing for Constant Gain with Temperature Constant Current Source** Thermometer LM313

*Adjust for 0V at 0°C †Adjust for 100 mV/°C

TL/H/5713-5

Physical Dimensions inches (millimeters)





Order Number LM113H, LM113H/883, LM113-1H, LM113-1H/883, LM113-2H, LM113-2H/883 or LM313H NS Package Number H02A

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